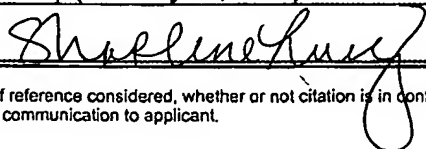


FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) Submitted to the PTO: February 2, 2004			ATTY DOCKET NO. 03560.002897.1		APPLICATION NO. To be assign d		
			APPLICANTS KOHEI NAKATA, ET AL.				
			FILING DATE February 2, 2004		GROUP 2831		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
82		6,254,449	07/2001	Nakanishi, et al.	445	25	
82		6,617,767	09/2003	Juen	445	25	
82		6,596,141	07/2003	Rasmussen	445	24	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
82		11-135018	05/1999	Japan			Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
82		W.P. Dyke, et al., "Field Emission", Advances in Electronics and Electron Physics, Vol. VIII, pp. 89-185 (1956).					
82		C.A. Spindt, et al., "Physical Properties of Thin-Film Emission Cathodes with Molybdenum Cones", Journal of Applied Physics, Vol. 47, No. 12, pp. 5248-5263 (December 1976).					
82		C.A. Mead, "Operation of Tunnel-Emission Devices", Journal of Applied Physics, Vol. 32, No. 4, pp. 646-652 (April 1961).					
82		M.I. Elinson, et al., "The Emission of Hot Electrons and the Field Emission of Electrons from Tin Oxide", Radio Engineering and Electronic Physics, No. 7, pp. 1290-1296 (July 1965).					
82		G. Dittmer, "Electrical Conduction and Electron Emission of Discontinuous Thin Films", Thin Solid Films, Vol. 9, pp. 317-329 (1972).					
82		M. Hartwell, et al., "Strong Electron Emission from Patterned Tin-Indium Oxide Thin Films", International Electron Devices Meeting, pp. 519-521 (1975).					
82		H. Araki, et al., "Electroforming and Electron Emission of Carbon Thin Films", pp. 22-29 (January 26, 1983).					
EXAMINER				DATE CONSIDERED			
				5/3/05			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.